2SK0663 (2SK663)

Silicon N-channel junction FET

For low-frequency amplification For switching circuits

■ Features

- Low noise figure NF
- High gate-drain voltage (source open) V_{GDO}
- SMini type package, allowing downsizing of the sets and automatic insertion through the tape/magazine packing

■ Absolute Maximum Ratings $T_a = 25^{\circ}C$

| Parameter | Symbol | Rating | Unit | |
|----------------------------------|------------------|-------------|------|--|
| Drain-sourse voltage | V_{DS} | 55 | V | |
| Gate-drain voltage (Source open) | V_{GDO} | -55 | V | |
| Gate-source voltage (Drain open) | V_{GSO} | -55 | V | |
| Drain current | I_{D} | 30 | mA | |
| Gate current | I_G | 10 | mA | |
| Power dissipation | P_{D} | 150 | mW | |
| Channel temperature | T _{ch} | 150 | °C | |
| Storage temperature | T_{stg} | -55 to +150 | °C | |

Package

- Code
- SMini3-G1
- Pin Name
 - 1: Source
 - 2: Drain
- 3: Gate
- Marking Symbol: 2B

■ Electrical Characteristics $T_a = 25$ °C ± 3 °C

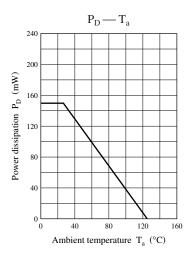
| Parameter | Symbol | Conditions | Min | Тур | Max | Unit |
|--|--------------------|--|------|-----|------|------|
| Gate-drain surrender voltage | V _{GDS} | $I_G = -100 \mu\text{A}, V_{DS} = 0$ | 55 | 80 | | V |
| Drain-source current * | I_{DSS} | $V_{DS} = 10 \text{ V}, V_{GS} = 0$ | 1.0 |)- | 12.0 | mA |
| Gate-source cutoff current | I_{GSS} | $V_{GS} = -30 \text{ V}, V_{DS} = 0$ | 1.90 | | -10 | nA |
| Gate-source cutoff voltage | V _{GSC} | $V_{DS} = 10 \text{ V}, I_D = 10 \mu\text{A}$ | | | -5 | V |
| Forward transfer admittance | Y _{fs} | $V_{DS} = 10 \text{ V}, I_D = 5 \text{ mA}, f = 1 \text{ kHz}$ | 2.5 | 7.5 | | mS |
| Short-circuit forward transfer capacitance (Common source) | C _{iss} | $V_{DS} = 10 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz}$ | | 6.5 | | pF |
| Reverse transfer capacitance | C _{rss} | is whi | | 1.9 | | pF |
| (Common source) | orss | ase woill | | 1.7 | | PI |
| Noise figure | NF | $V_{DS} = 10 \text{ V}, V_{GS} = 0, f = 100 \text{ Hz}$ | | 2.5 | | dB |
| | | $R_g = 100 \text{ k}\Omega$ | | | | |

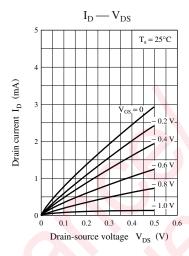
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

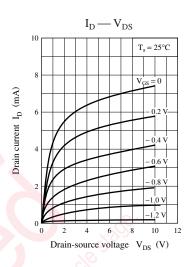
2. *: Rank classification

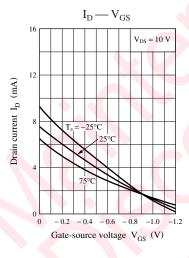
| • | Rank | Р | Q | R | |
|---|-----------------------|------------|------------|-------------|--|
| | I _{DSS} (mA) | 1.0 to 3.0 | 2.0 to 6.5 | 5.0 to 12.0 | |

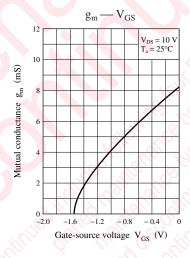
Note) The part number in the parenthesis shows conventional part number.

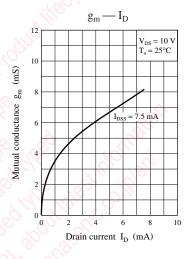


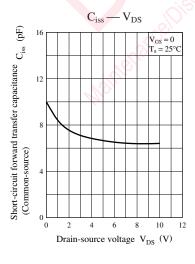


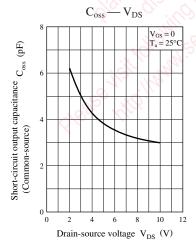






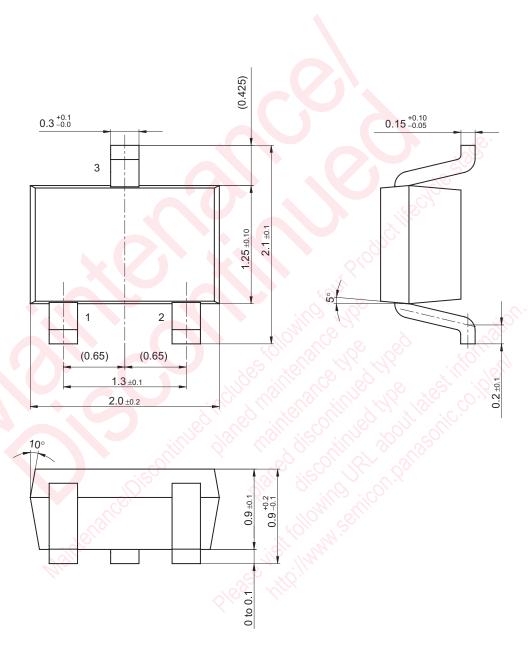






2 SJF00010CED

SMini3-G1 Unit: mm



SJF00010CED 3

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